| Application Number | 10/542,077 | | Filing Date (YYYY-MM-DD) | 2005-07-13 | Filing Date (YYYY-MM-DD) | 2005-07-13 | Filing Date (YYYY-MM-DD) | 7 | Takeshi BANDOH et al. | 7 | Takeshi BANDOH et al.

U.S. PATENTS

EXAMINER INITIAL	U.S. PATENT NUMBER	ISSUE DATE (YYYY-MM-DD)	PATENTEE	CLASS	SUB- CLASS	FILING DATE (YYYY-MM-DD)			

U.S. PATENT APPLICATION PUBLICATIONS

EXAMINER INITIAL	U.S. PATENT APPLICATION PUBLICATION NUMBER	PUBL. DATE (YYYY-MM-DD)	PATENTEE	CLASS	SUB- CLASS	FILING DATE (YYYY-MM-DD)

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FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	FOREIGN PATENT DOCUMENT NUMBER	COUNTRY CODE	KIND	PUBL. DATE (YYYY-MM-DD)	NAME OF PATENTEE OR APPLICANT OF THE CITED DOCUMENT	TRANS	LATION NO
	2339503	CN		1999-09-22	HAN KECHANG (CN)		
	2145770	CN		1993-11-10	ZHAO WEIXIAN (CN)		
	1 138 608	EP	A1	2001-10-04	Uni-Charm Corporation		

NON-PATENT LITERATURE DOCUMENTS

EXAMINER INITIAL	Include name of the author (in CAPITAL LETTERS), title of the article symposium catalog, etc.) date, page(s), volume-issue number(s), put	(when appropriate), title of the item (book, magazine, journal, serial slisher, city and/or country where published.	TRANS YES	LATION NO
EXAMINER	/Ned Walker/	DATE CONSIDERED 12/03/2008		

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

(Form PTO-1449)